

ATM7414NDH

N-Channel Enhancement Mode Field Effect Transistor

Drain-Source Voltage: 30V

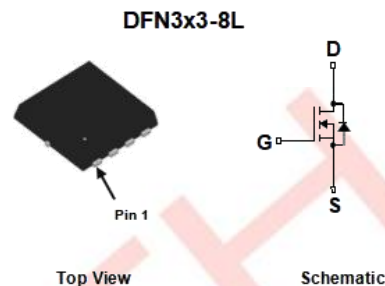
Drain Current: 18A

Description

The ATM7414NDH uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a load switch or in PWM applications. Standard Product ATM7414NDH is Pb-free.

Features

- ◆ $V_{DS}(V)=30V$
- ◆ $I_D=18A(V_{GS}=10V)$
- ◆ $R_{DS(ON)} < 16m\Omega (V_{GS}=10V)$
- ◆ $R_{DS(ON)} < 24m\Omega (V_{GS}=4.5V)$



Absolute maximum ratings (Ta=25°C unless otherwise noted)

Parameter	Symbol	Maximum	Unit	
Drain-Source Voltage	V_{DS}	30	V	
Gate-Source Voltage	V_{GS}	±20	V	
Continuous Drain Current ^{NOTE 2}	I_D	Ta=25°C	18	A
		Ta=70°C	13.5	
Pulsed Drain Current ^{NOTE 3}	I_{DM}	52	A	
Continuous Drain Current ^{NOTE 1}	I_{DSM}	Ta=25°C	12.5	A
		Ta=70°C	10	A
Avalanche energy L=0.3mH	E_{AS}	17.8	mJ	
Power Dissipation ^{NOTE 2}	P_D	Ta=25°C	10.7	W
		Ta=70°C	4.3	W
Power Dissipation ^{NOTE 1}	P_{DSM}	Ta=25°C	3.7	W
		Ta=70°C	2.4	W
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 150	°C	

Thermal Characteristics

Parameter		Symbol	Typ	Max	Unit
Maximum Junction-to-Ambient ^{NOET 1}	$t \leq 10s$	$R_{\theta JA}$	27	34	°C/W
Maximum Junction-to-Ambient ^{NOET 1}	Steady-State		52	65	°C/W
Maximum Junction-to-Case ^{NOET 1}	Steady-State	$R_{\theta JC}$	9.8	11.7	°C/W

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Electrical characteristics (T_A=25 °C, unless otherwise noted)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Static Characteristics						
Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = 250μA	30			V
Zero gate voltage drain current	I _{DSS}	V _{DS} = 24V, V _{GS} = 0V			1	μA
Gate-body leakage current	I _{GSS}	V _{GS} = ±20V, V _{DS} = 0V			±100	nA
Gate threshold voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250μA	1.0	1.6	2.0	V
Static Drain-source on-resistance ¹⁾	R _{DS(on)}	V _{GS} = 10V, I _D = 8.0A		12.8	16.0	mΩ
		V _{GS} = 4.5V, I _D = 7.0A		18.0	24.0	
Forward Transconductance	g _{FS}	V _{DS} = 5.0V, I _D = 8.0A		9.5		S
Diode Forward Voltage	V _{SD}	I _S = 1.0A, V _{GS} = 0V		0.75	1.2	V
Dynamic characteristics²⁾						
Input Capacitance	C _{iss}	V _{DS} = 15V, V _{GS} = 0V, f = 1MHz		645		pF
Output Capacitance	C _{oss}			87		
Reverse Transfer Capacitance	C _{rss}			68		
Gate resistance	R _g	V _{GS} = 0V, V _{DS} = 0V, f = 1MHz		1.5		Ω
Total Gate Charge	Q _{gtot} (10V)	V _{GS} = 10V, V _{DS} = 15V, I _D = 8.0A		15.5		nC
Total Gate Charge	Q _{gtot} (4.5V)			7.5		nC
Gate Source Charge	Q _{gs}			2.6		nC
Gate Drain Charge	Q _{gd}			2.7		nC
Turn-on delay time	t _{d(on)}	V _{DS} = 15V, R _L = 2Ω, V _{GS} = 10V, R _{GEN} = 3Ω		6.0		ns
Turn-on rise time	t _r			18.0		
Turn-off delay time	t _{d(off)}			27.5		
Turn-off fall time	t _f			9.8		

Notes:

- The value of R_{θJA} is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_A = 25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t ≤ 10s thermal resistance rating.
- The Power dissipation PD is based on T_J(MAX) = 150°C, using junction to case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heat sinking is used.
- Repetitive rating, pulse width limited by junction temperature.
- The R_{θJA} is the sum of the thermal impedance from junction to case R_{θJC} and case to ambient.
- The static characteristics in Figures 1 to 6 are obtained using 80 μs pulses, duty cycle 0.5% max.
- These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_A = 25°C. The SOA curve provides a single pulse rating.
- The maximum current rating is package limit.

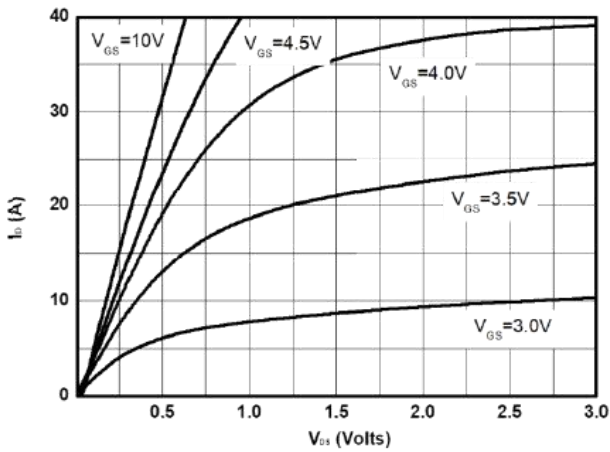


Fig 1: On-Region Characteristics

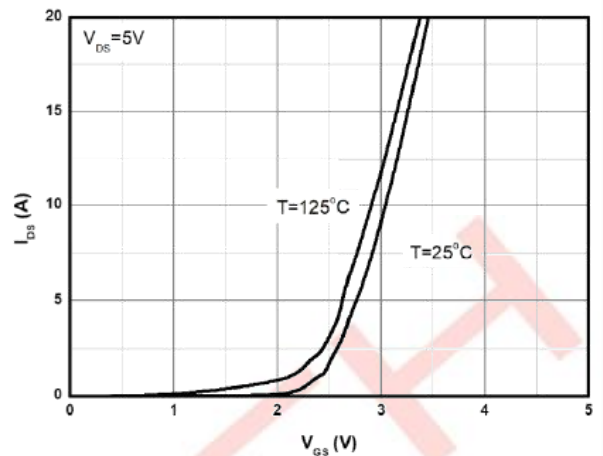


Figure 2: Transfer Characteristics

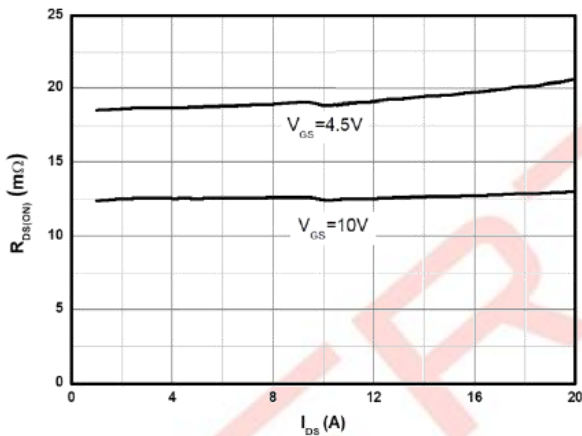


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

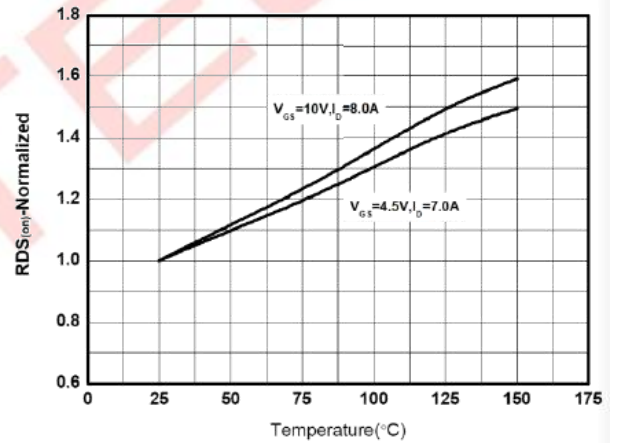


Figure 4: On-Resistance vs. Junction Temperature

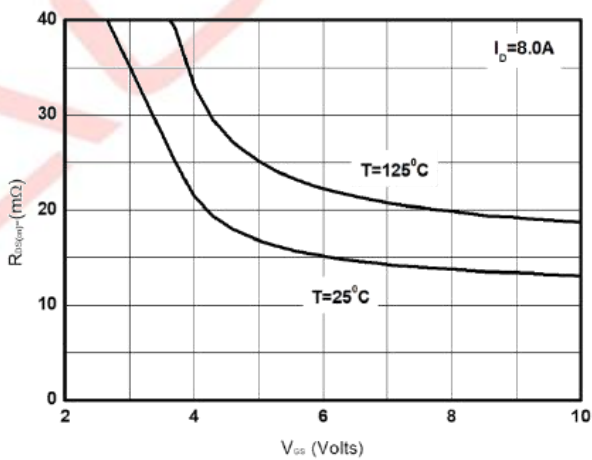


Figure 5: On-Resistance vs Gate-Source

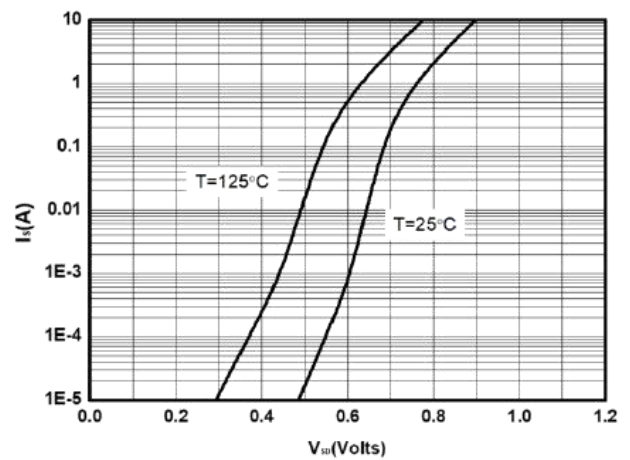


Figure 6: Body-Diode Characteristics

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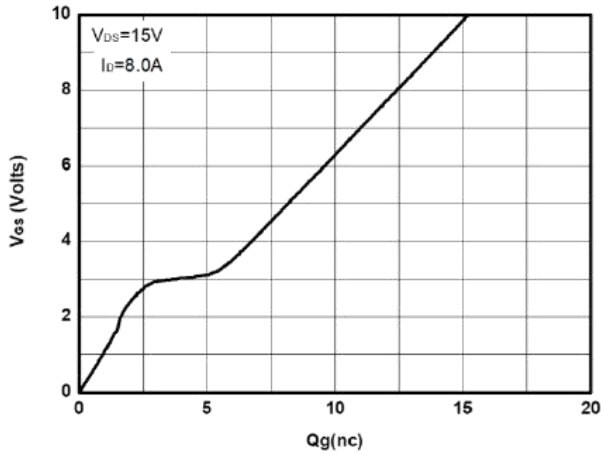


Figure 7: Gate-Charge Characteristics

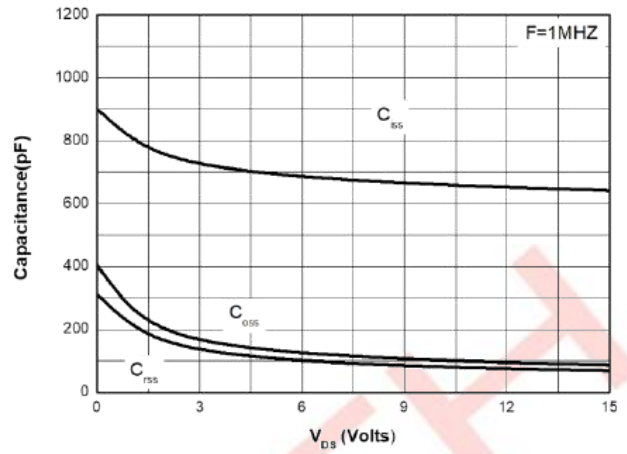


Figure 8: Capacitance Characteristics

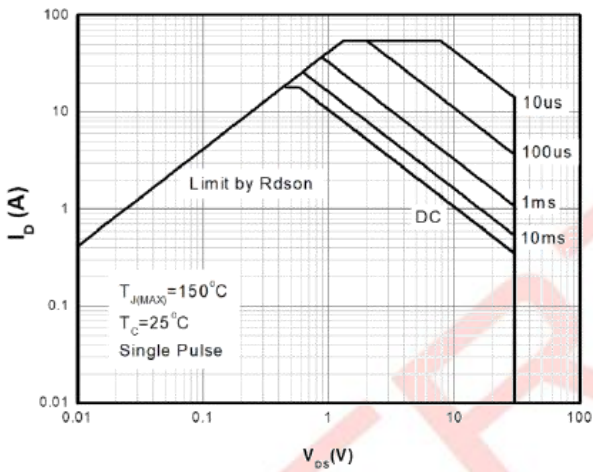


Figure 9: Maximum Forward Biased Safe Operating Area (Note 2)

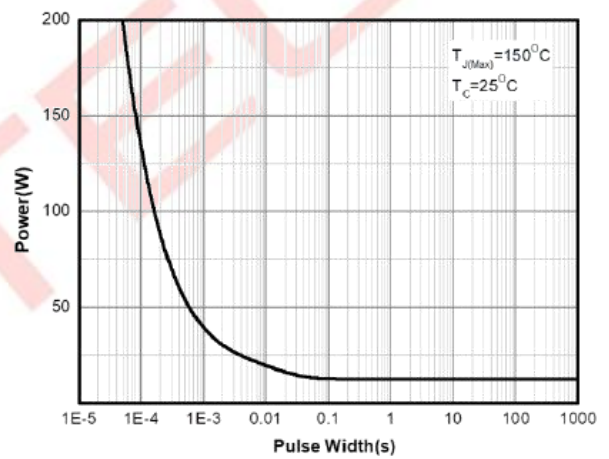


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note 2)

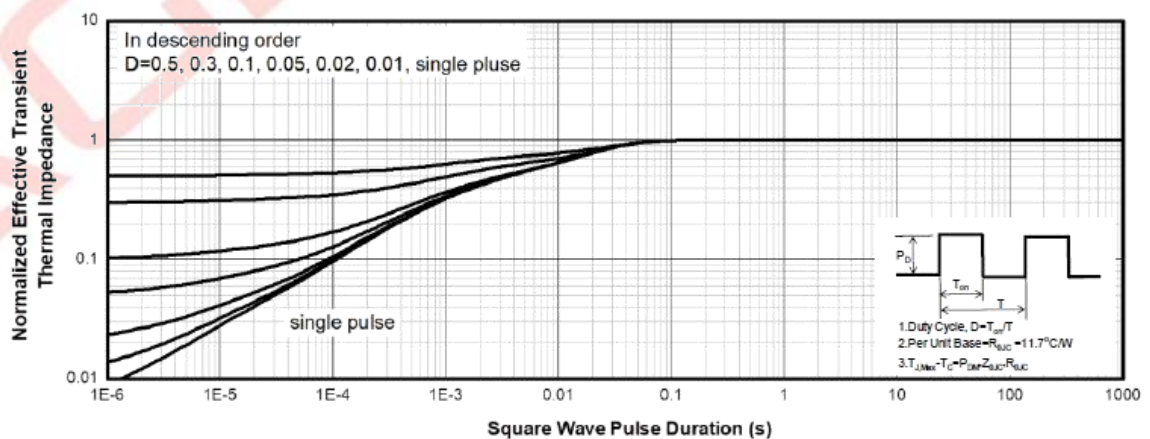


Figure 11: Normalized Maximum Transient Thermal Impedance (Note 2)

